Power MOSFET

40 V, 6.9 m Ω , 44 A, Dual N–Channel Logic Level, Dual SO–8FL

Features

- Small Footprint (5x6 mm) for Compact Designs
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- NVMFD5852NLWF Wettable Flanks Option for Enhanced Optical Inspection
- AEC-Q101 Qualified and PPAP Capable
- This is a Pb–Free Device

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V _{DSS}	40	V
Gate-to-Source Voltage)		V_{GS}	±20	V
Continuous Drain Current R _{ΨJ-mb} (Notes 1,		$T_{mb} = 25^{\circ}C$	I _D	44	Α
2, 3, 4)	Steady	$T_{mb} = 100^{\circ}C$		31	
Power Dissipation	State	$T_{mb} = 25^{\circ}C$	P_{D}	27	W
$R_{\Psi J-mb}$ (Notes 1, 2, 3)		$T_{mb} = 100^{\circ}C$		13	
Continuous Drain Cur-		$T_A = 25^{\circ}C$	I _D	15	Α
rent R _{0JA} (Notes 1, 3 & 4)	Steady State	T _A = 100°C		10.6	
Power Dissipation		T _A = 25°C	P_{D}	3.2	W
R _{θJA} (Notes 1 & 3)		T _A = 100°C		1.6	
Pulsed Drain Current $T_A = 25^{\circ}C$, $t_p = 10 \mu s$			I _{DM}	329	Α
Operating Junction and Storage Temperature			T _J , T _{stg}	-55 to 175	°C
Source Current (Body Diode)			I _S	40	Α
Single Pulse Drain–to–Source Avalanche Energy (T _J = 25°C, V _{GS} = 10 V, I _{L(pk)} = 40 A, L = 0.1 mH, R _G = 25 Ω)			E _{AS}	80	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			T_L	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS (Note 1)

Parameter	Symbol	Value	Unit
Junction-to-Mounting Board (top) - Steady State (Notes 2, 3)	$R_{\Psi J-mb}$	5.6	°C/W
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	47	

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Psi (Ψ) is used as required per JESD51–12 for packages in which substantially less than 100% of the heat flows to single case surface.
- 3. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- 4. Maximum current for pulses as long as 1 second are higher but are dependent on pulse duration and duty cycle.

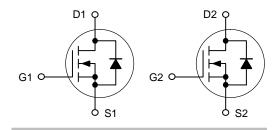


ON Semiconductor®

http://onsemi.com

V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX	
40 V	6.9 mΩ @ 10 V	44 A	
	12.0 mΩ @ 4.5 V	77 /	

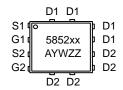
Dual N-Channel





CASE 506BT

MARKING DIAGRAM



5852NL = Specific Device Code for NVMFD5852NL

5852LW = Specific Device Code for NVMFD5852NLWF

= Assembly Location

Y = Year
W = Work Week
ZZ = Lot Traceability

ORDERING INFORMATION

Device	Package	Shipping [†]
NVMFD5852NLT1G	DFN8 (Pb-Free)	1500 / Tape & Reel
NVMFD5852NLWFT1G	DFN8 (Pb-Free)	1500 / Tape & Reel

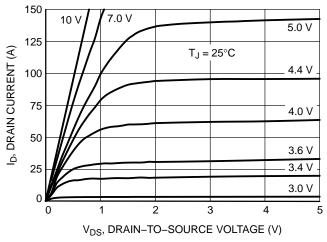
†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS			•				
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$		40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				37.3		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	T _J = 25°C			1.0	μΑ
		$V_{DS} = 40 \text{ V}$	T _J = 125°C			100	1
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS}$	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = V_{DS}$	= 250 μΑ	1.4		2.4	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				6.3		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V, I _D	= 20 A		5.3	6.9	mΩ
		V _{GS} = 4.5 V, I _E	₀ = 20 A		8.7	12	1
Forward Transconductance	9 _{FS}	$V_{DS} = 5 \text{ V}, I_{D}$	= 5 A		24		S
CHARGES AND CAPACITANCES							
Input Capacitance	C _{iss}				1800		pF
Output Capacitance	C _{oss}	V _{GS} = 0 V, f = 1.0 MH	Iz, V _{DS} = 25 V		240		<u> </u>
Reverse Transfer Capacitance	C _{rss}		-		180		
Total Gate Charge	Q _{G(TOT)}				20		nC
Threshold Gate Charge	Q _{G(TH)}	$V_{GS} = 4.5 \text{ V}, V_{D}$	s = 32 V,		1.5		7
Gate-to-Source Charge	Q_{GS}		$I_D = 20 \text{ A}$		5.5		7
Gate-to-Drain Charge	Q_{GD}				10.9		1
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 32V, I _D = 20 A			36		nC
SWITCHING CHARACTERISTICS (No	ote 6)						
Turn-On Delay Time	t _{d(on)}				12		ns
Rise Time	t _r	$V_{GS} = 4.5 \text{ V}, V_{D}$	s = 32 V,		52		
Turn-Off Delay Time	t _{d(off)}	$V_{GS} = 4.5 \text{ V}, V_{D}$ $I_{D} = 20 \text{ A}, R_{G}$	= 2.5 Ω		21		
Fall Time	t _f				13		1
Turn-On Delay Time	t _{d(on)}				12		ns
Rise Time	t _r	$V_{GS} = 10 \text{ V}, V_{DS}$	s = 32 V,		8.0		1
Turn-Off Delay Time	t _{d(off)}	$I_D = 20 \text{ A}, R_G = 2.5 \Omega$			27		1
Fall Time	t _f				5.0		1
DRAIN-SOURCE DIODE CHARACTE	RISTICS						
Forward Diode Voltage	V_{SD}	V _{GS} = 0 V,	T _J = 25°C		0.84	1.1	V
-		$I_{S} = 20 \text{ A}$	T _J = 125°C		0.69		1
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V, } d_{IS}/d_t = 100 \text{ A/}\mu\text{s,}$ $I_S = 20 \text{ A}$			22.3		ns
Charge Time	t _a				12.8		1
Discharge Time	t _b				9.4		1
Reverse Recovery Charge	Q _{RR}				15.2		nC

^{5.} Pulse Test: pulse width = 300 μs, duty cycle ≤ 2%.
6. Switching characteristics are independent of operating junction temperatures.

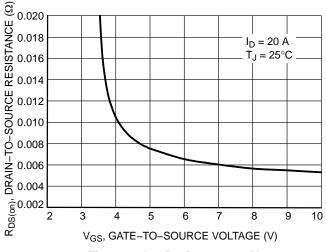
TYPICAL CHARACTERISTICS



150 $V_{DS} \ge 10 \text{ V}$ 125 ID, DRAIN CURRENT (A) 100 75 50 T_J = 25°C 25 $T_{J} = 125^{\circ}$ $T_J = -55^{\circ}C$ 0 2.0 2.5 3.0 3.5 4.0 4.5 5.0 V_{GS}, GATE-TO-SOURCE VOLTAGE (V)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



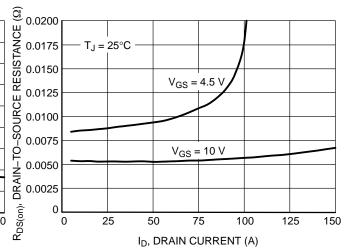
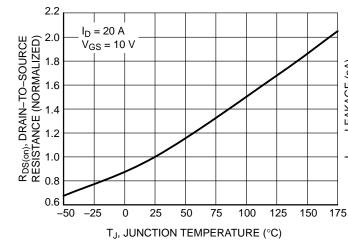


Figure 3. On-Resistance vs. V_{GS}

Figure 4. On–Resistance vs. Drain Current and Gate Voltage



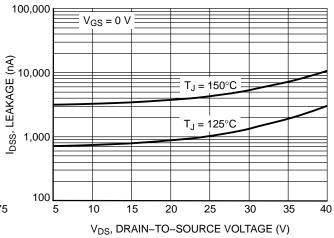
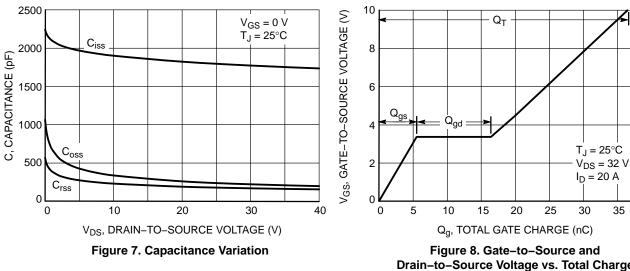
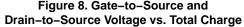


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS





35

40

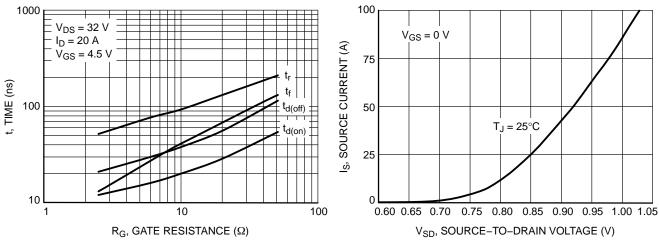


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 10. Diode Forward Voltage vs. Current

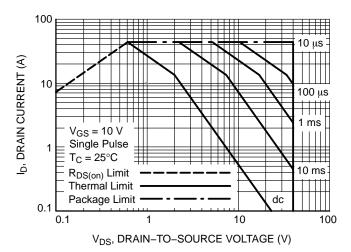


Figure 11. Maximum Rated Forward Biased Safe Operating Area

TYPICAL CHARACTERISTICS

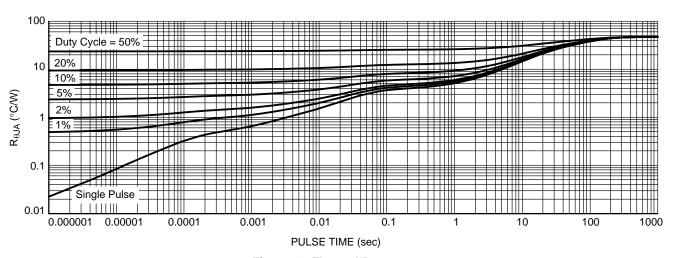


Figure 12. Thermal Response



D

D1

TOP VIEW

SIDE VIEW

SCALE 2:1

PIN ONE IDENTIFIER

0.10 C

C 0.10

NOTE 7

NOTE 4

DFN8 5x6, 1.27P Dual Flag (SO8FL-Dual)

0.20 C

В

E1 E

SEATING PLANE

C

0.20 C

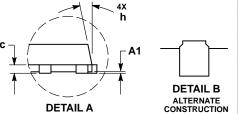
A

CASE 506BT ISSUE F

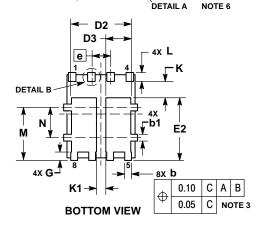
DATE 23 NOV 2021



- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: MILLIMETERS.
- DIMENSION 6 APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.30 MM FROM THE TERMINAL TIP.
- PROFILE TOLERANCE APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.
- DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD FLASH,
- PROTRUSIONS, OR GATE BURRS.
 SEATING PLANE IS DEFINED BY THE TERMINALS. A1 IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.
- 7. A VISUAL INDICATOR FOR PIN 1 MUST BE LOCATED IN THIS AREA.



	MILLIMETERS				
DIM	MIN	NOM	MAX		
Α	0.90	-	1.10		
A1			0.05		
b	0.33	0.42	0.51		
b1	0.33	0.42	0.51		
С	0.20		0.33		
D		5.15 BSC			
D1	4.70	4.90	5.10		
D2	3.90	4.10	4.30		
D3	1.50	1.70	1.90		
E		6.15 BSC			
E1	5.70	5.90	6.10		
E2	3.90	4.15	4.40		
е	1.27 BSC				
G	0.45	0.55	0.65		
h		-	12 °		
K	0.51	-			
K1	0.56				
L	0.48	0.61	0.71		
М	3.25	3.50	3.75		
N	1.80	2.00	2.20		



GENERIC MARKING DIAGRAM*



XXXXXX = Specific Device Code

= Assembly Location Α

Υ = Year W = Work Week = Lot Traceability ZZ

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

SOLDERING FOOTPRINT* 4.56 2.08 8X 0.56 0.75 4X 6.59 4.84 1.40 2.30 3.70 0.70 4X 1.00 1.27 **PITCH** 5.55 **DIMENSION: MILLIMETERS**

*For additional information on our Pb-Free strategy and soldering details, please download the onsemi Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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DESCRIPTION:	DFN8 5X6, 1.27P DUAL FLAG (SO8FL-DUAL)		PAGE 1 OF 1

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